

**Search Notes**

Application/Control No.

10/625,794

Examiner

Quan Tra

Applicant(s)/Patent under  
Reexamination

SHIRATO, KEIJI

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
limited search 327/530, 536, 589	8/4/2006	QT